

Notice of References Cited	Application/Control No. 10/632,948		Applicant(s)/Patent Under Reexamination TOUR ET AL.	
	Examiner Matthew W. Such		Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,117,617	09-2000	Kanayama et al.	430/296
*	C	US-5,547,748	08-1996	Ruoff et al.	428/323
*	D	US-6,448,412	09-2002	Murphy et al.	548/417
*	E	US-5,717,076	02-1998	Yamamoto et al.	534/558
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NON-PATENT DOCUMENTS

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	U	Chen, J. et al. SCIENCE. Vol. 286 (19 November 1999): Pages 1550-1552.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.